# isc Silicon NPN Power Transistor

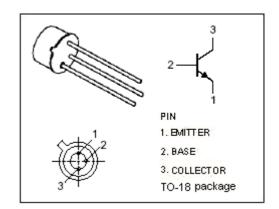
2N2222

#### **DESCRIPTION**

- Collector Current- I<sub>C</sub>= 0.8A
- · Collector-Emitter Breakdown Voltage-
  - : V<sub>(BR)CEO</sub>= 30V(Min)
- Complement to Type 2N2907

#### **APPLICATIONS**

 Designed for general-purpose switching and linear amplification.



# **ABSOLUTE MAXIMUM RATINGS(Ta=25℃)**

SYMBOL	PARAMETER		UNIT
V <sub>CBO</sub>	Collector-Base Voltage	60	V
V <sub>CEO</sub>	Collector-Emitter Voltage	30	V
V <sub>EBO</sub>	Emitter-Base Voltage	5	V
Ic	Collector Current-Continuous	0.8	Α
I <sub>BM</sub>	Base Current-Peak	0.2	А
P <sub>C</sub>	Collector Power Dissipation@T <sub>C</sub> =25℃	0.5	W
T <sub>J</sub>	Junction Temperature	150	$^{\circ}$ C
T <sub>stg</sub>	Storage Temperature	-65~150	$^{\circ}$

### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	MAX	UNIT
R <sub>th j-a</sub>	Thermal Resistance, Junction to Ambient	350	K/W

isc Website: www.iscsemi.cn

# isc Silicon NPN Power Transistor

2N2222

### **ELECTRICAL CHARACTERISTICS**

T<sub>C</sub>=25℃ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
V <sub>(BR) CEO</sub>	Collector-Emitter Breakdown Voltage	I <sub>C</sub> =10mA ; I <sub>B</sub> =0	30		V
V <sub>(BR)EBO</sub>	Emitter-Base Breakdown Voltage	I <sub>E</sub> =10 μ A ; I <sub>C</sub> =0	5		V
V <sub>CE(sat)-1</sub>	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 150mA; I <sub>B</sub> = 15mA		0.4	V
V <sub>CE(sat)-2</sub>	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 500mA; I <sub>B</sub> = 50mA		1.6	V
V <sub>BE(sat)-1</sub>	Base-Emitter Saturation Voltage	I <sub>C</sub> = 150mA; I <sub>B</sub> = 15mA		1.3	V
V <sub>BE(sat)-2</sub>	Base-Emitter Saturation Voltage	I <sub>C</sub> = 500mA; I <sub>B</sub> = 50mA		2.6	V
I <sub>CBO</sub>	Collector Cutoff Current	V <sub>CB</sub> = 50V; I <sub>E</sub> =0		1.5	uA
I <sub>EBO</sub>	Emitter Cutoff Current	V <sub>EB</sub> = 5V; I <sub>C</sub> =0		50	nA
h <sub>FE-1</sub>	DC Current Gain	I <sub>C</sub> = 0.1mA ; V <sub>CE</sub> = 10V	35		
h <sub>FE-2</sub>	DC Current Gain	I <sub>C</sub> = 1mA; V <sub>CE</sub> = 10V	50		
h <sub>FE-3</sub>	DC Current Gain	I <sub>C</sub> = 10mA ; V <sub>CE</sub> = 10V	75		
h <sub>FE-4</sub>	DC Current Gain	I <sub>C</sub> = 150mA ; V <sub>CE</sub> = 10V	100	300	
h <sub>FE-5</sub>	DC Current Gain	I <sub>C</sub> = 500mA ; V <sub>CE</sub> = 10V	30		
f <sub>T</sub>	Current Gain-Bandwidth Product	I <sub>C</sub> = 20mA ; V <sub>CE</sub> = 20V;f <sub>test</sub> = 100MHz	250		MHz
Сов	Output Capacitance	I <sub>E</sub> = 0 ; V <sub>CB</sub> = 10V; f <sub>test</sub> = 1.0MHz		8	pF
Switching T	ïmes				
t <sub>d</sub>	Delay Time	I <sub>C</sub> = 150mA; I <sub>B1</sub> = -I <sub>B2</sub> = 15mA		10	ns
t <sub>r</sub>	Rise Time			25	ns
t <sub>stg</sub>	Storage Time			200	ns
t <sub>f</sub>	Fall Time			60	ns